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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of	
Kazuya KAMON	Group Art Unit: 1756
Application No.: 09/320,946	Examiner: S. Mohamedulla
Filed: May 26, 1999))
For: PHOTOMASK, FABRICATION METHOD OF PHOTOMASK, AND FABRICATION METHOD OF SEMICONDUCTOR INTEGRATED CIRCUIT	PRECEIVED RECHMOLOGY CENTER 1780 Pate: April 4 2001
PRELIMINARY AMENDMENT /STATEMENT	
Assistant Commissioner for Patents Washington, D.C. 20231	Date: April 4, 2001

This preliminary amendment is filed in order to facilitate processing in the above-identified application and is filed in response to the Advisory Action dated March 14, 2001 (Paper No. 8).

REMARKS

This preliminary amendment is filed in order to respond to note no. 6 in the Advisory Action dated March 14, 2001. In particular, Applicant respectfully traverse the Examiner's statement "while *Hur* and *Lee* do not specifically teach chemical-mechanical polishing the phase shift film, it is an obvious variation of *Hur* or *Lee* to polish it as the references teach performing chemical-mechanical polishing on other areas of the mask. Applicant argues that *Hur* and *Lee* do not teach a reflection preventing film, however, they teach a light shading film". Applicant respectfully point out that a reflection preventing